Power MOSFET 75 Amps, 60 Volts, Logic Level N–Channel TO–220 and D²PAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

$\begin{array}{ c c c c c } \hline Rating & Symbol & Value & Unit \\ \hline Drain-to-Source Voltage & V_{DSS} & 60 & Vdc \\ \hline Drain-to-Gate Voltage (R_{GS} = 10 M\Omega) & V_{DGR} & 60 & Vdc \\ \hline Gate-to-Source Voltage & V_{GS} & \pm 20 & Vdc \\ \hline - Continuous & V_{GS} & \pm 15 & Vdc \\ \hline - Non-Repetitive (t_p \leq 10 ms) & V_{GS} & \pm 15 & Vdc \\ \hline Drain Current & ID & 75 & Adc \\ \hline - Continuous @ T_A = 25^{\circ}C & ID & 75 & Adc \\ \hline - Continuous @ T_A = 100^{\circ}C & ID & 50 & \\ \hline - Single Pulse (t_p \leq 10 \ \mu s) & IDM & 225 & Apk \\ \hline Total Power Dissipation @ T_A = 25^{\circ}C & P_D & 214 & W \\ \hline Derate above 25^{\circ}C & P_D & 214 & W \\ \hline Operating and Storage Temperature Range & T_J, T_{Stg} & -55 to & ^{\circ}C \\ \hline +175 & \\ \hline Single Pulse Drain-to-Source Avalanche \\ Energy - Starting T_J = 25^{\circ}C & P_D & 214 & M \\ \hline \end{array}$,		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rating	Symbol	Value	Unit
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-to-Source Voltage	VDSS	60	Vdc
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain–to–Gate Voltage (R_{GS} = 10 M Ω)	VDGR	60	Vdc
$\begin{tabular}{ c c c c c c } \hline -& Non-Repetitive (t_p \le 10 \text{ ms}) & V_{GS} & \pm 15 \\ \hline Drain Current & & I_D & 75 & Adc \\ & -& Continuous @ T_A = 25^\circ C & I_D & 50 & \\ & -& Single Pulse (t_p \le 10 \ \mu s) & I_DM & 225 & Apk \\ \hline Total Power Dissipation @ T_A = 25^\circ C & P_D & 214 & W \\ Derate above 25^\circ C & & 1.4 & W/^\circ C \\ \hline Total Power Dissipation @ T_A = 25^\circ C (Note 1.) & 2.4 & W \\ \hline Operating and Storage Temperature Range & T_J, T_{Stg} & -55 \ to & +175 & \\ \hline Single Pulse Drain-to-Source Avalanche & E_{AS} & 844 & mJ \\ \hline Energy - Starting T_J = 25^\circ C & \hline \end{tabular}$	Gate-to-Source Voltage			Vdc
$\begin{tabular}{ c c c c c c } \hline -& Non-Repetitive (t_p \le 10 \text{ ms}) & V_{GS} & \pm 15 \\ \hline Drain Current & & I_D & 75 & Adc \\ & -& Continuous @ T_A = 25^\circ C & I_D & 50 & \\ & -& Single Pulse (t_p \le 10 \ \mu s) & I_DM & 225 & Apk \\ \hline Total Power Dissipation @ T_A = 25^\circ C & P_D & 214 & W \\ Derate above 25^\circ C & & 1.4 & W/^\circ C \\ \hline Total Power Dissipation @ T_A = 25^\circ C (Note 1.) & 2.4 & W \\ \hline Operating and Storage Temperature Range & T_J, T_{Stg} & -55 \ to & +175 & \\ \hline Single Pulse Drain-to-Source Avalanche & E_{AS} & 844 & mJ \\ \hline Energy - Starting T_J = 25^\circ C & \hline \end{tabular}$	 Continuous 	VGS	± 20	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	– Non–Repetitive (t _p ≤10 ms)		±15	
$\label{eq:constraint} \begin{array}{ c c c } - & Continuous @ T_A = 100^\circ C & I_D & 50 \\ \hline & - & Single Pulse (t_p \leq 10 \ \mu s) & I_DM & 225 & Apk \\ \hline & I_DM & 225 & Apk \\ \hline & I_DM & 225 & P_D & 214 & W \\ \hline & Derate above 25^\circ C & 1.4 & W/^\circ C \\ \hline & Total Power Dissipation @ T_A = 25^\circ C (Note 1.) & 2.4 & W \\ \hline & Operating and Storage Temperature Range & T_J, T_{Stg} & -55 \ to & +175 \\ \hline & Single Pulse Drain-to-Source Avalanche & E_{AS} & 844 & mJ \\ \hline & Energy - Starting T_J = 25^\circ C & \hline & & & \\ \hline \end{array}$				
$\label{eq:logical_states} \begin{array}{ c c c } - & \text{Single Pulse} (t_p \leq 10 \ \mu\text{s}) & \text{I}_{DM} & 225 & \text{Apk} \\ \hline \text{Total Power Dissipation @ } T_A = 25^\circ\text{C} & P_D & 214 & W \\ \hline \text{Derate above } 25^\circ\text{C} & 1.4 & W/^\circ\text{C} \\ \hline \text{Total Power Dissipation @ } T_A = 25^\circ\text{C} \ (\text{Note 1.}) & 2.4 & W \\ \hline \text{Operating and Storage Temperature Range} & T_J, \ T_{Stg} & -55 \ \text{to} & \circ^{\text{C}} \\ +175 & & \\ \hline \text{Single Pulse Drain-to-Source Avalanche} & E_{AS} & 844 & \text{mJ} \\ \hline \text{Energy} - \ \text{Starting } T_J = 25^\circ\text{C} & & \\ \hline \end{array}$		۱D	75	Adc
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		۱ _D	50	
$\begin{tabular}{ c c c c c c c } \hline Derate above 25^{\circ}C & 1.4 & W/^{\circ}C \\ \hline Total Power Dissipation @ T_A = 25^{\circ}C (Note 1.) & 2.4 & W \\ \hline Operating and Storage Temperature Range & T_J, T_{Stg} & -55 to & ^{\circ}C \\ & +175 & & \\ \hline Single Pulse Drain-to-Source Avalanche & E_{AS} & 844 & mJ \\ \hline Energy - Starting T_J = 25^{\circ}C & & \\ \hline \end{array}$	– Single Pulse ($t_p \le 10 \ \mu s$)	IDM	225	Apk
Total Power Dissipation @ $T_A = 25^{\circ}C$ (Note 1.)2.4WOperating and Storage Temperature Range T_J, T_{Stg} -55 to $+175$ $^{\circ}C$ $+175$ Single Pulse Drain-to-Source Avalanche Energy - Starting $T_J = 25^{\circ}C$ EAS844mJ	Total Power Dissipation @ T _A = 25°C	PD	214	W
Operating and Storage Temperature RangeTJ, Tstg-55 to +175°C +Single Pulse Drain-to-Source Avalanche Energy – Starting TJ = 25°CEAS844mJ	Derate above 25°C		1.4	W/°C
Single Pulse Drain-to-Source Avalanche EAS 844 mJ Energy – Starting TJ = 25°C Filler Filler Filler	Total Power Dissipation @ $T_A = 25^{\circ}C$ (Note 1.)		2.4	W
Single Pulse Drain-to-Source Avalanche EAS 844 mJ Energy – Starting TJ = 25°C Filler Filler Filler	Operating and Storage Temperature Range	TJ, Tstg	-55 to	°C
Energy – Starting T _J = 25°C		,	+175	
	0	EAS	844	mJ
	$(V_{DD} = 50 \text{ Vdc}, V_{GS} = 5.0 \text{ Vdc}, L = 0.3 \text{ mH}$			
I _{L(pk)} = 75 A, V _{DS} = 60 Vdc)	$I_{L(pk)} = 75 \text{ A}, V_{DS} = 60 \text{ Vdc}$			
Thermal Resistance °C/W	Thermal Resistance			°C/W
– Junction–to–Case R ₀ JC 0.7	 Junction-to-Case 	R ₀ JC	0.7	
– Junction–to–Ambient (Note 1.) $R_{\theta JA}$ 62.5	– Junction–to–Ambient (Note 1.)		62.5	
Maximum Lead Temperature for Soldering TL 260 °C	Maximum Lead Temperature for Soldering	ΤL	260	°C
Purposes, 1/8" from case for 10 seconds	Purposes, 1/8" from case for 10 seconds			

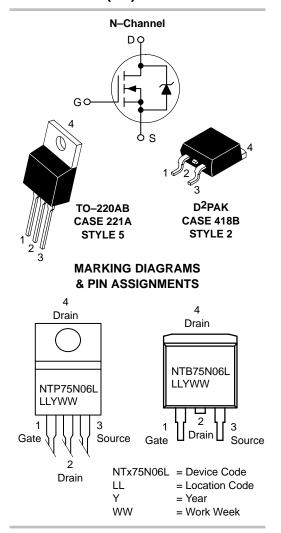
 When surface mounted to an FR4 board using minimum recommended pad size, (Cu Area 0.412 in²).



ON Semiconductor[™]

http://onsemi.com

75 AMPERES 60 VOLTS RDS(on) = 11 mΩ



ORDERING INFORMATION

Device	Package	Shipping
NTP75N06L	TO-220AB	50 Units/Rail
NTB75N06L	D ² PAK	50 Units/Rail
NTB75N06LT4	D ² PAK	800/Tape & Reel

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain–to–Source Breakdown Voltage (Note 2.) (V _{GS} = 0 Vdc, I _D = 250 μ Adc) Temperature Coefficient (Positive)			60 -	72 74		Vdc mV/°C
Zero Gate Voltage Drain Curr ($V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vd}$ ($V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vd}$	IDSS			10 100	μAdc	
Gate-Body Leakage Current	$(V_{GS} = \pm 15 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	IGSS	-	-	±100	nAdc
ON CHARACTERISTICS (Note	2.)					
Gate Threshold Voltage (Note 2.) $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coefficient (Negative)			1.0	1.58 6.0	2.0	Vdc mV/°C
Static Drain-to-Source On-R (V _{GS} = 5.0 Vdc, I _D = 37.5 /	R _{DS(on)}	_	9.0	11	mOhm	
Static Drain-to-Source On-Voltage (Note 2.) (V _{GS} = 5.0 Vdc, I _D = 75 Adc) (V _{GS} = 5.0 Vdc, I _D = 37.5 Adc, T _J = 150°C)		VDS(on)		0.75 0.61	0.99 -	Vdc
Forward Transconductance (N	Note 2.) (V _{DS} = 15 Vdc, I _D = 37.5 Adc)	9FS	_	55	-	mhos
YNAMIC CHARACTERISTIC	s					
Input Capacitance		C _{iss}	-	3122	4370	pF
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{OSS}	-	1029	1440	
Transfer Capacitance		C _{rss}	-	276	390	
WITCHING CHARACTERIST	ICS (Note 3.)					
Turn–On Delay Time		^t d(on)	-	22	32	ns
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 75 \text{ Adc},$	tr	-	265	370	
Turn–Off Delay Time	$V_{GS} = 5.0 \text{ Vdc}, R_{G} = 9.1 \Omega$ (Note 2.)	^t d(off)	-	113	160	
Fall Time		t _f	-	170	240	
Gate Charge	(V _{DS} = 48 Vdc, I _D = 75 Adc, V _{GS} = 5.0 Vdc) (Note 2.)	QT	-	66	92	nC
		Q ₁	_	9.0	_	
		Q ₂	_	47	_	
OURCE-DRAIN DIODE CHA	RACTERISTICS					
Forward On–Voltage	$(I_S = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 2.)}$ $(I_S = 75 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$	V _{SD}	_ _	1.0 0.9	1.15 –	Vdc
Reverse Recovery Time		t _{rr}	-	70	-	ns
	(I _S = 75 Adc, V _{GS} = 0 Vdc, dI _S /dt = 100 A/μs) (Note 2.)	^t a	_	43	_	
		tb	_	27	-	

Reverse Recovery Stored Charge

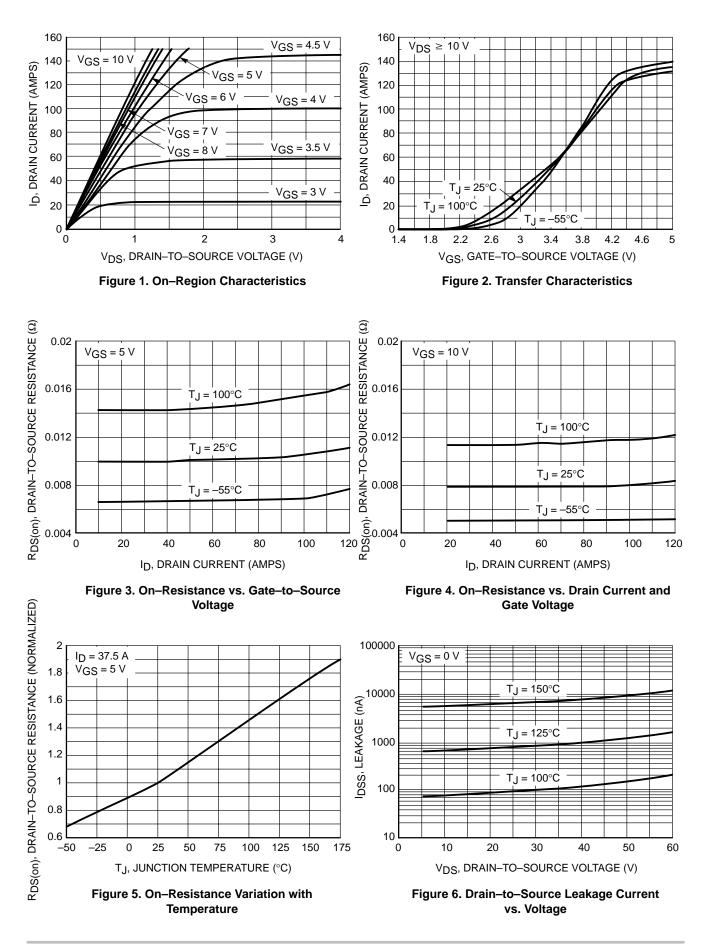
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

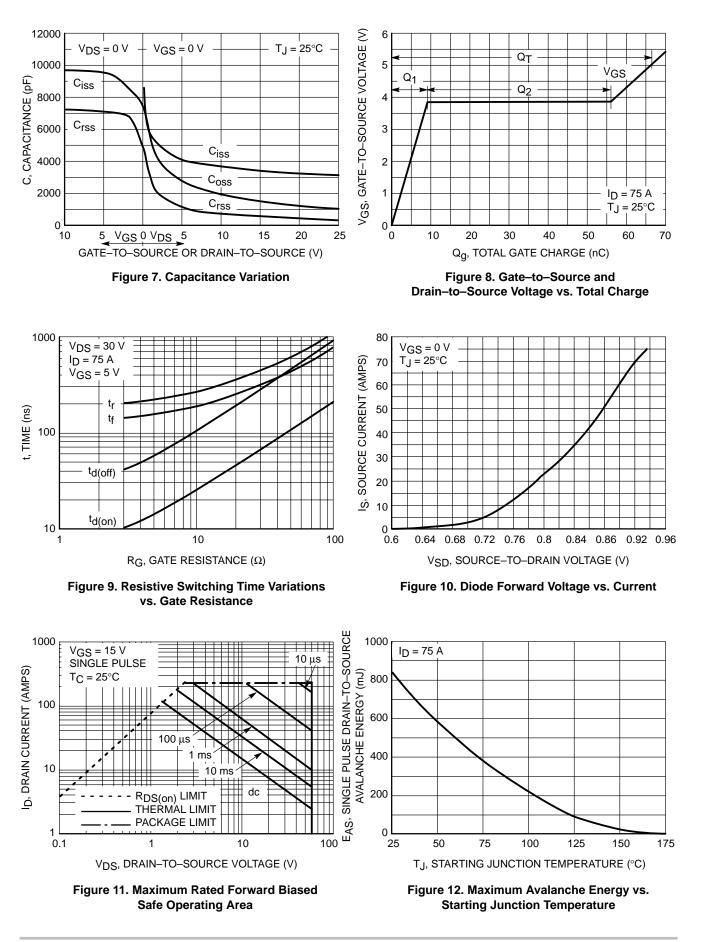
0.16

 Q_{RR}

μC

_





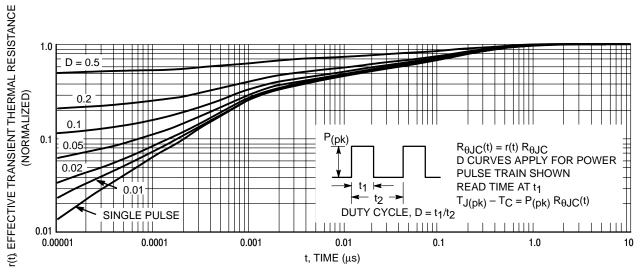
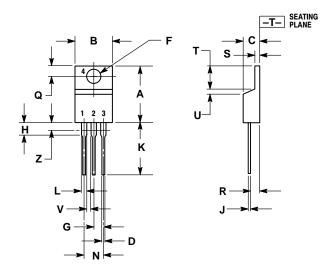


Figure 13. Thermal Response

PACKAGE DIMENSIONS

TO-220 THREE-LEAD TO-220AB CASE 221A-09 **ISSUE AA**



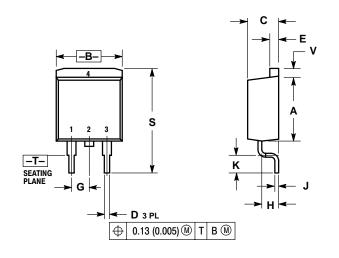
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES MILLIM		IETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
Κ	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
Ν	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Ζ		0.080		2.04

STYLE 5: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

D²PAK CASE 418B-03 ISSUE D



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2 CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
C	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
E	0.045	0.055	1.14	1.40	
G	0.100 BSC		2.54 BSC		
Н	0.080	0.110	2.03	2.79	
J	0.018	0.025	0.46	0.64	
K	0.090	0.110	2.29	2.79	
S	0.575	0.625	14.60	15.88	
٧	0.045	0.055	1.14	1.40	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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